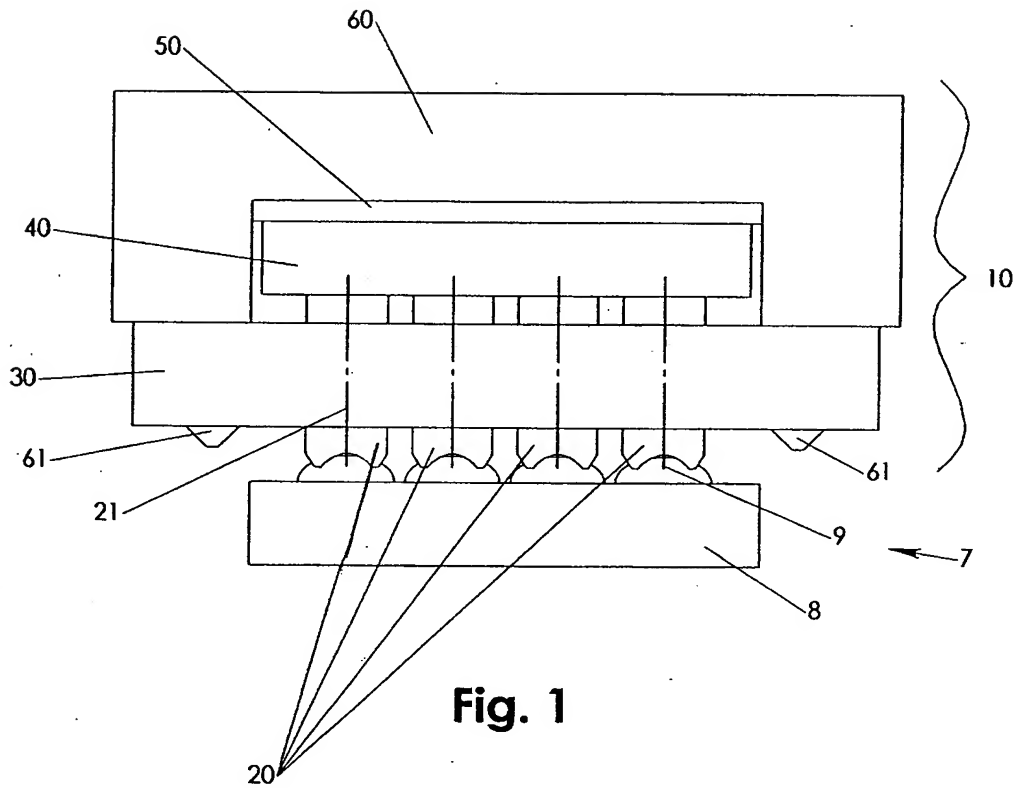




TEST PIN BACK SURFACE IN PROBE APPARATUS FOR LOW WEAR  
MULTIPLE CONTACTING WITH CONDUCTIVE ELASTOMER  
JIACHUN ZHOU; JANUARY KISTER  
CUSTOMER NO. 23122 DOCKET NO. K&S-151US



**Fig. 1**